

E3M0075120K

Silicon Carbide Power MOSFET

E-Series Automotive

N-Channel Enhancement Mode



Features

- 3rd generation SiC MOSFET technology
- Optimized package with separate driver source pin
- 8mm of creepage distance between drain and source
- High blocking voltage with low on-resistance
- High-speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery (Q_{rr})
- Halogen free, RoHS compliant
- Automotive Qualified (AEC-Q101) and PPAP Capable

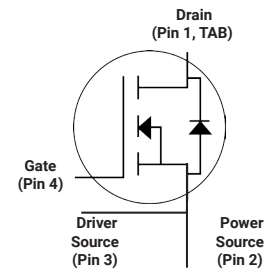
Benefits

- Reduce switching losses and minimize gate ringing
- Higher system efficiency
- Reduce cooling requirements
- Increase power density
- Increase system switching frequency

Applications

- EV battery chargers
- High Voltage DC/DC converters

Package



Ordering Part Number	Package	Marking
E3M0075120K	TO 247-4	E3M0075120K

Maximum Ratings ($T_c = 25^\circ\text{C}$ unless otherwise specified)

Stress beyond those listed under absolute maximum ratings may cause permanent damage to the device.

Symbol	Parameter		Value	Unit	Note
V _{DSmax}	Drain - Source Voltage		1200	V	
V _{GSmax}	Gate - Source Voltage		-8/+19	V	Note: 1
I _D	Continuous Drain Current, V _{GS} = 15 V	T _C = 25°C	32	A	Fig. 19, Note: 2
		T _C = 100°C	23		
I _{D(pulse)}	Pulsed Drain Current, Pulse width t _p limited by T _{jmax}		80	A	Fig. 22
P _D	Power Dissipation, T _c =25°C, T _J = 175 °C		145	W	Fig. 20 Note: 2
T _J , T _{stg}	Operating Junction and Storage Temperature		-55 to +175	°C	
T _L	Solder Temperature, 1.6mm (0.063”) from case for 10s		260	°C	
M _d	Mounting Torque , M3 or 6-32 screw		1	Nm	
			8.8	lbf-in	

Note (1): Recommended turn off / turn on gate voltage $V_{GS} = -4V...0V / +15V$

Note (2): Verified by design

Electrical Characteristics (T_C = 25°C unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
V _{(BR)DSS}	Drain-Source Breakdown Voltage	1200			V	V _{GS} = 0 V, I _D = 100 μA	
V _{GS(th)}	Gate Threshold Voltage	1.8	2.6	3.6	V	V _{DS} = V _{GS} , I _D = 5 mA	Fig. 11
			2.1		V	V _{DS} = V _{GS} , I _D = 5 mA, T _J = 175°C	
I _{DSS}	Zero Gate Voltage Drain Current		1	50	μA	V _{DS} = 1200 V, V _{GS} = 0 V	
I _{GSS}	Gate-Source Leakage Current		10	250	nA	V _{GS} = 15 V, V _{DS} = 0 V	
R _{DS(on)}	Drain-Source On-State Resistance		75	97.5	mΩ	V _{GS} = 15 V, I _D = 17.9 A	Fig. 4, 5, 6
			135			V _{GS} = 15 V, I _D = 17.9 A, T _J = 175°C	
g _{fs}	Transconductance		11		S	V _{DS} = 20 V, I _D = 17.9 A	Fig. 7
			10.5			V _{DS} = 20 V, I _D = 17.9 A, T _J = 175°C	
C _{iss}	Input Capacitance		1480		pF	V _{GS} = 0 V, V _{DS} = 1000 V f = 1 MHz V _{AC} = 25 mV	Fig. 17, 18
C _{oss}	Output Capacitance		58				
C _{rss}	Reverse Transfer Capacitance		2.7				
E _{oss}	C _{oss} Stored Energy		32		μJ		Fig. 16
C _{o(er)}	Effective Output Capacitance (Energy Related)		67		pF	V _{GS} = 0 V, V _{DS} = 0... 800V	Note (2)
C _{o(tr)}	Effective Output Capacitance (Time Related)		96		pF		
E _{ON}	Turn-On Switching Energy (External Diode)		280		μJ	V _{DS} = 800 V, V _{GS} = -4 V/15 V, I _D = 20 A, R _{G(ext)} = 2.5 Ω, L = 98 μH, FWD = External SiC Diode	Fig. 26, 29
E _{OFF}	Turn Off Switching Energy (External Diode)		56				
E _{ON}	Turn-On Switching Energy (Body Diode FWD)		280		μJ	V _{DS} = 800 V, V _{GS} = -4 V/15 V, I _D = 20 A, R _{G(ext)} = 2.5 Ω, L = 156 μH, FWD = Body Diode of MOSFET	Fig. 26, 29
E _{OFF}	Turn-Off Switching Energy (Body Diode FWD)		63				
t _{d(on)}	Turn-On Delay Time		8		ns	V _{DD} = 800 V, V _{GS} = -4 V/15 V I _D = 20 A, R _{G(ext)} = 2.5 Ω, Timing relative to V _{DS} Inductive load	Fig. 27, 28
t _r	Rise Time		22				
t _{d(off)}	Turn-Off Delay Time		29				
t _f	Fall Time		11				
R _{G(int)}	Internal Gate Resistance		9.0		Ω	f = 1 MHz, V _{AC} = 25 mV	
Q _{gs}	Gate to Source Charge		17		nC	V _{DS} = 800 V, V _{GS} = -4 V/15 V I _D = 17.9 A Per IEC60747-8-4 pg 21	Fig. 12
Q _{gd}	Gate to Drain Charge		18				
Q _g	Total Gate Charge		55				

Note (2): C_{o(er)}, a lumped capacitance that gives same stored energy as C_{oss} while V_{ds} is rising from 0 to 800V
C_{o(tr)}, a lumped capacitance that gives same charging time as C_{oss} while V_{ds} is rising from 0 to 800V

Reverse Diode Characteristics ($T_c = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
V_{SD}	Diode Forward Voltage	4.8		V	$V_{GS} = -4\text{ V}, I_{SD} = 9\text{ A}$	Fig. 8, 9, 10
		4.2		V	$V_{GS} = -4\text{ V}, I_{SD} = 9\text{ A}, T_J = 175^\circ\text{C}$	
I_S	Continuous Diode Forward Current		27	A	$V_{GS} = -4\text{ V}, T_J = 25^\circ\text{C}$	
$I_{S, \text{pulse}}$	Diode pulse Current		80	A	$V_{GS} = -4\text{ V}$, Pulse width t_p limited by $T_{j\text{max}}$	
t_{rr}	Reverse Recover time	20		ns	$V_{GS} = -4\text{ V}, I_{SD} = 20\text{ A}, V_R = 800\text{ V}$ $\text{dif}/\text{dt} = 5280\text{ A}/\mu\text{s}, T_J = 175^\circ\text{C}$	
Q_{rr}	Reverse Recovery Charge	376		nC		
I_{rm}	Peak Reverse Recovery Current	25		A		
t_{rr}	Reverse Recover time	28		ns	$V_{GS} = -4\text{ V}, I_{SD} = 20\text{ A}, V_R = 800\text{ V}$ $\text{dif}/\text{dt} = 1305\text{ A}/\mu\text{s}, T_J = 175^\circ\text{C}$	
Q_{rr}	Reverse Recovery Charge	338		nC		
I_{rm}	Peak Reverse Recovery Current	16		A		

Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
$R_{\theta JC}$	Thermal Resistance from Junction to Case	0.88	1.03	$^\circ\text{C}/\text{W}$		Fig. 21

Typical Performance

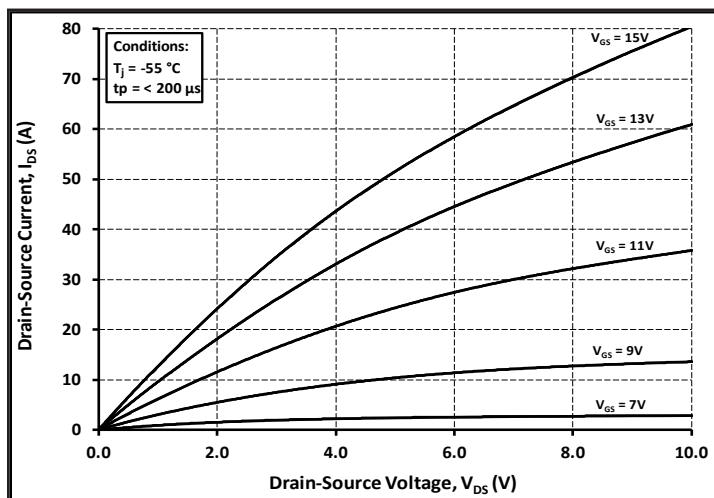


Figure 1. Output Characteristics $T_J = -55\text{ }^{\circ}\text{C}$

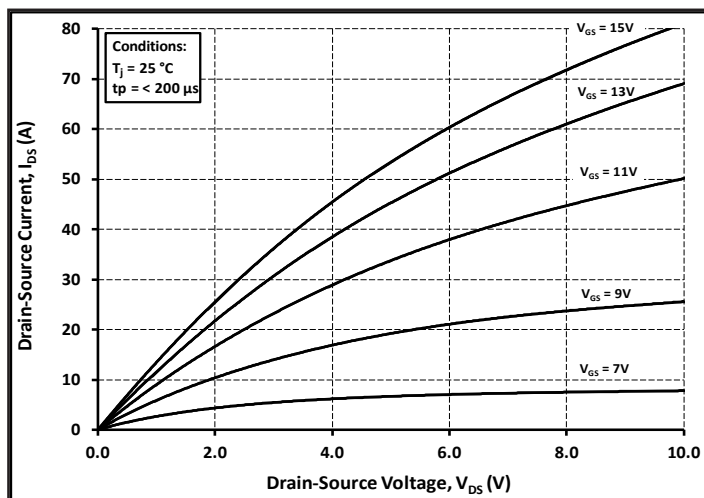


Figure 2. Output Characteristics $T_J = 25\text{ }^{\circ}\text{C}$

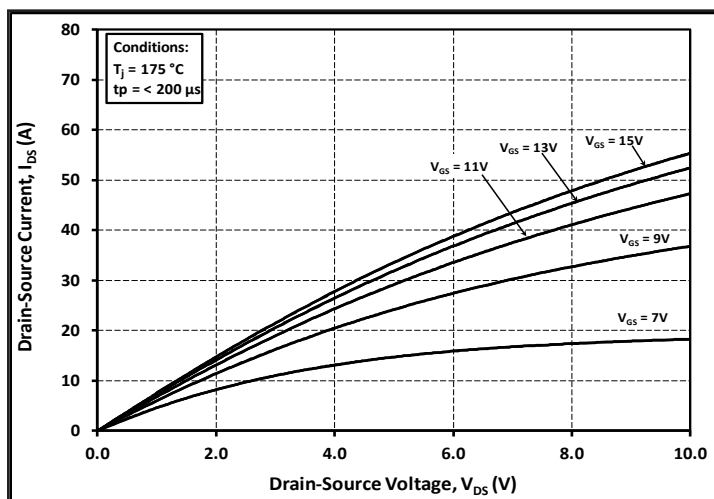


Figure 3. Output Characteristics $T_J = 175\text{ }^{\circ}\text{C}$

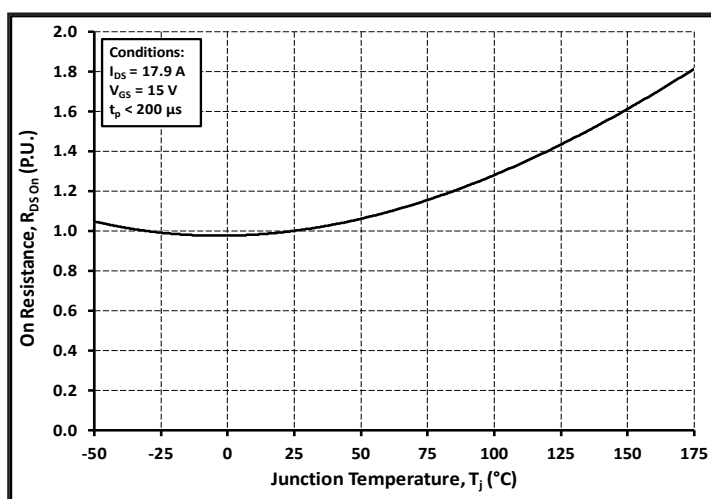


Figure 4. Normalized On-Resistance vs. Temperature

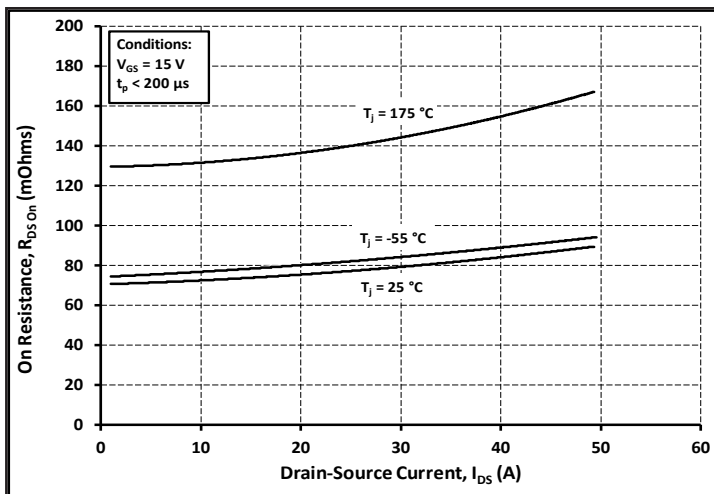


Figure 5. On-Resistance vs. Drain Current
For Various Temperatures

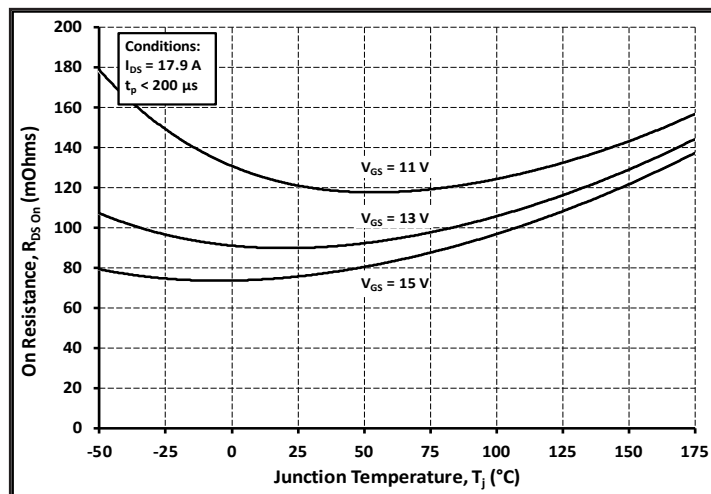


Figure 6. On-Resistance vs. Temperature
For Various Gate Voltage

Typical Performance

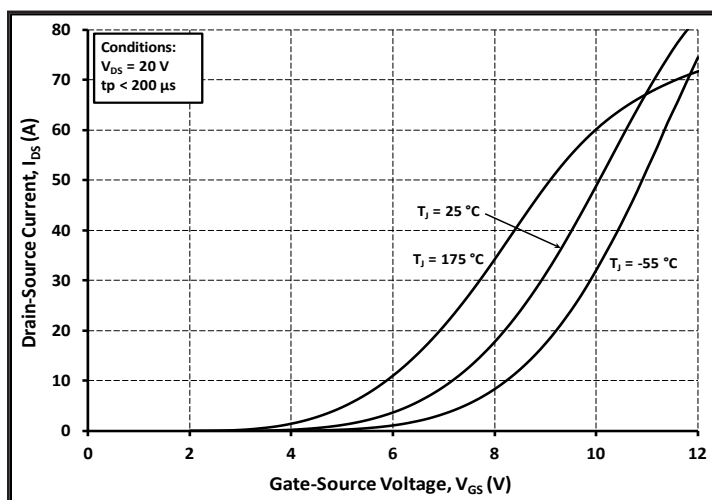


Figure 7. Transfer Characteristic for Various Junction Temperatures

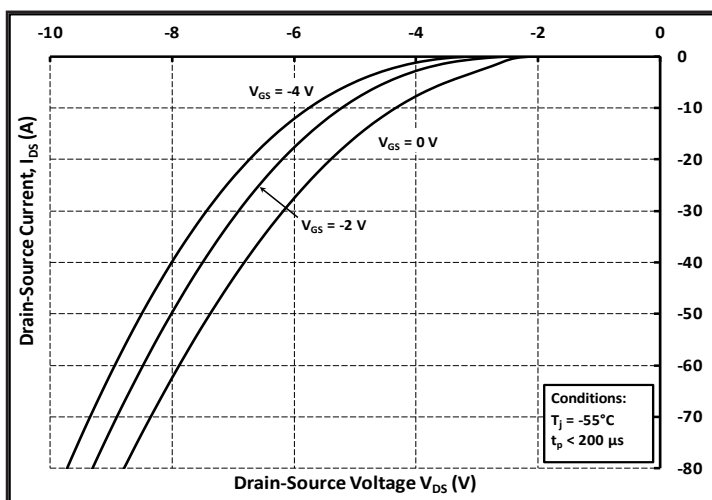


Figure 8. Body Diode Characteristic at $-55\text{ }^{\circ}\text{C}$

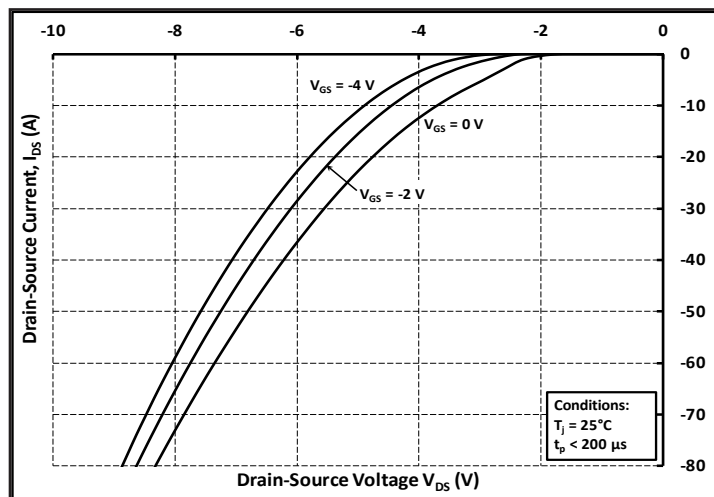


Figure 9. Body Diode Characteristic at $25\text{ }^{\circ}\text{C}$

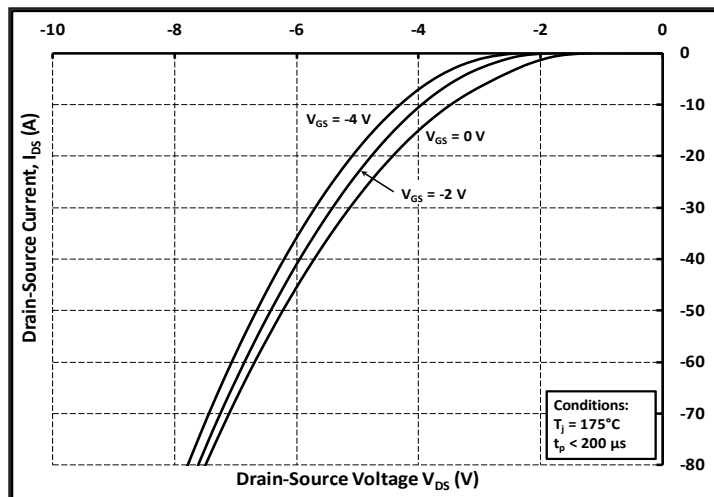


Figure 10. Body Diode Characteristic at $175\text{ }^{\circ}\text{C}$

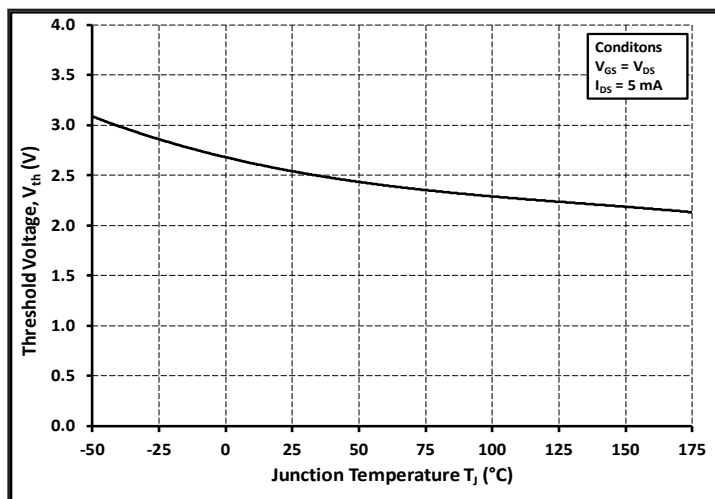


Figure 11. Threshold Voltage vs. Temperature

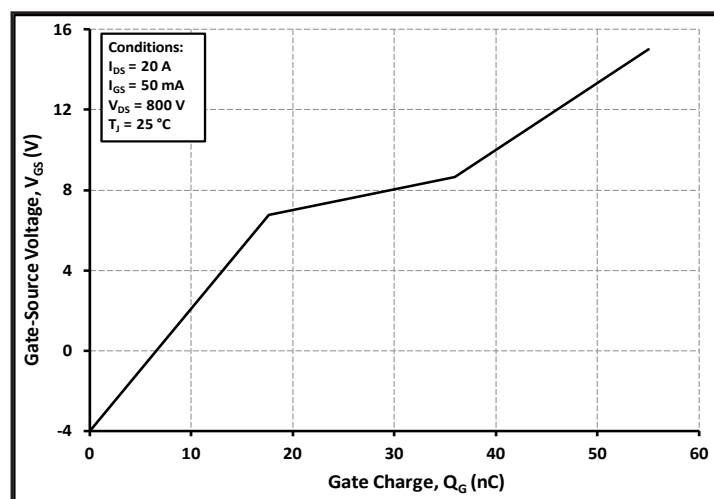


Figure 12. Gate Charge Characteristics

Typical Performance

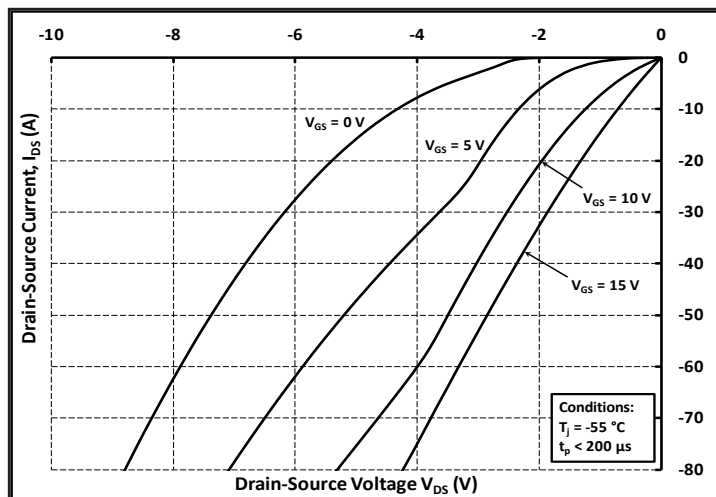


Figure 13. 3rd Quadrant Characteristic at -55 °C

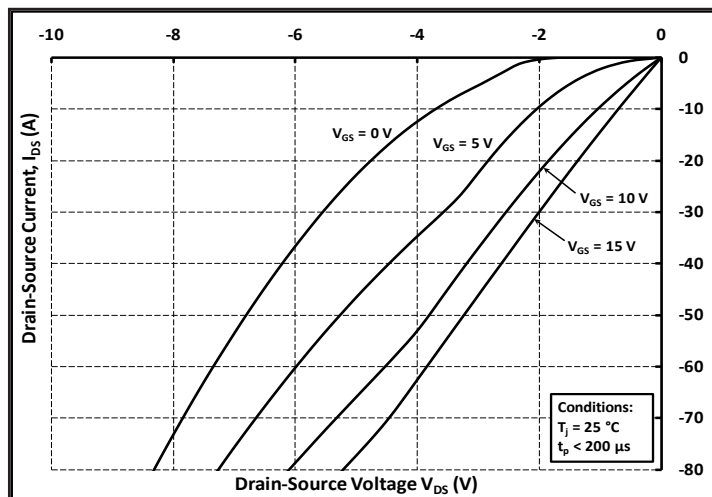


Figure 14. 3rd Quadrant Characteristic at 25 °C

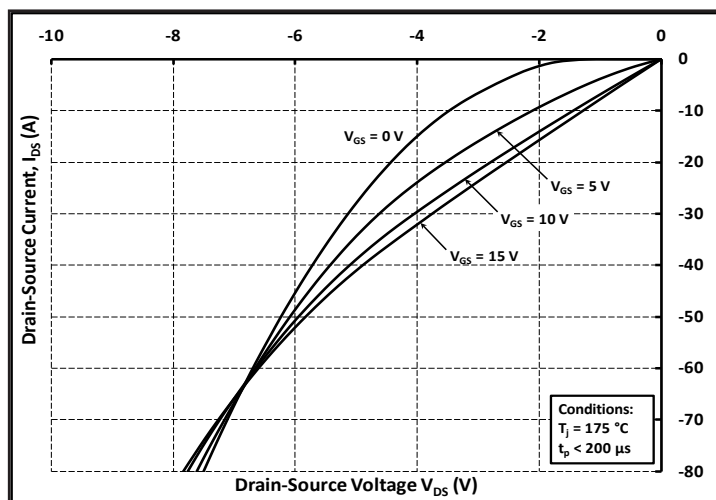


Figure 15. 3rd Quadrant Characteristic at 175 °C

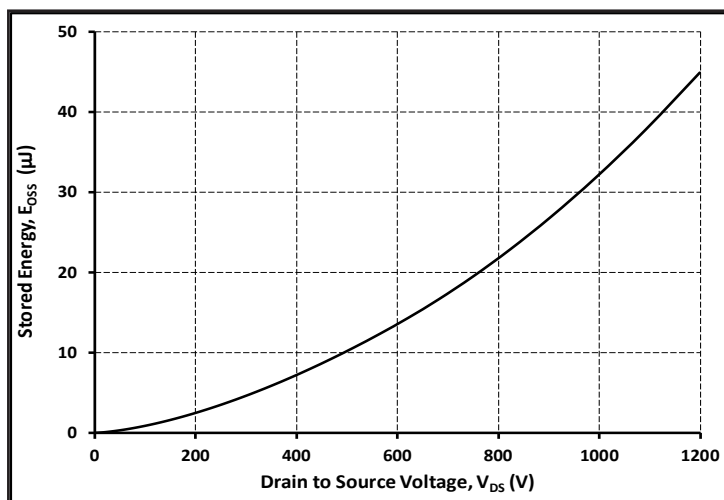


Figure 16. Output Capacitor Stored Energy

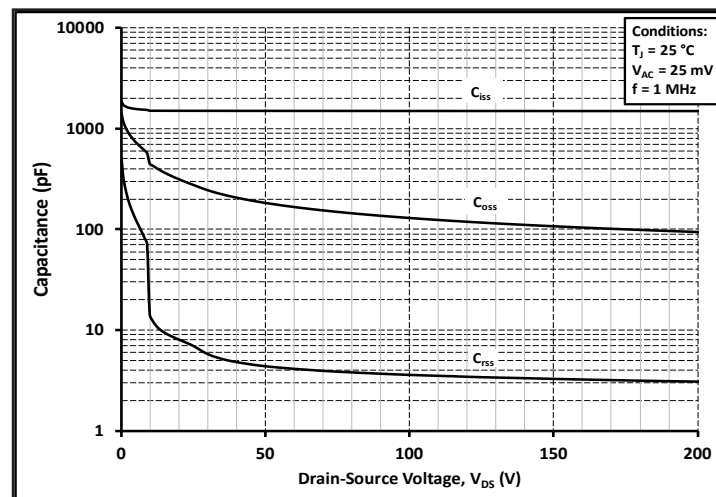


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)

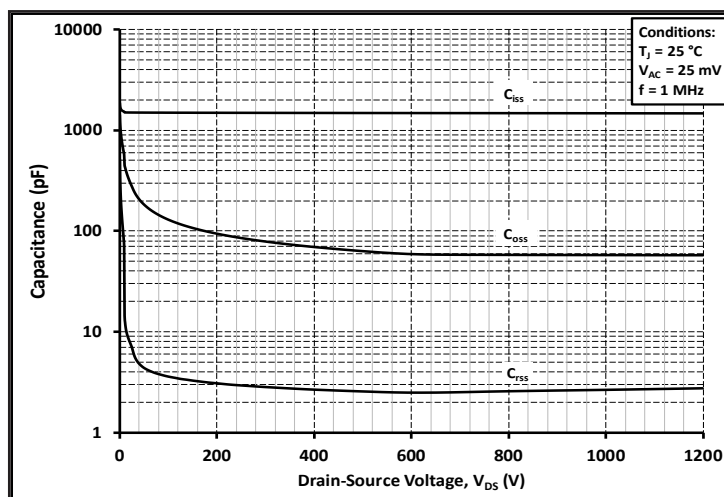


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 1000V)

Typical Performance

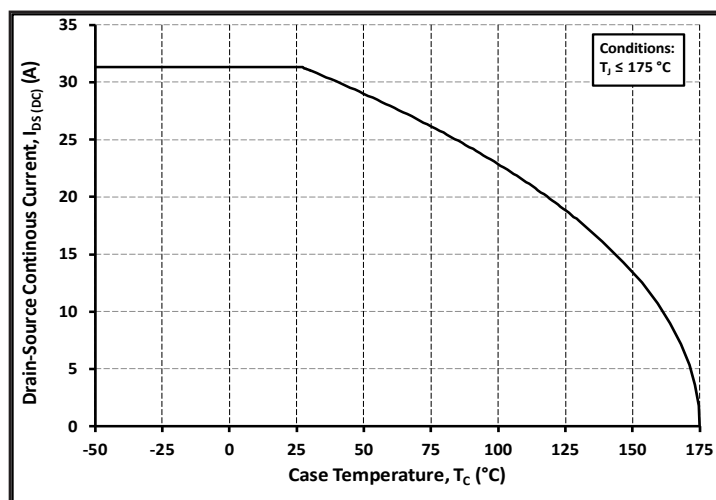


Figure 19. Continuous Drain Current Derating vs. Case Temperature

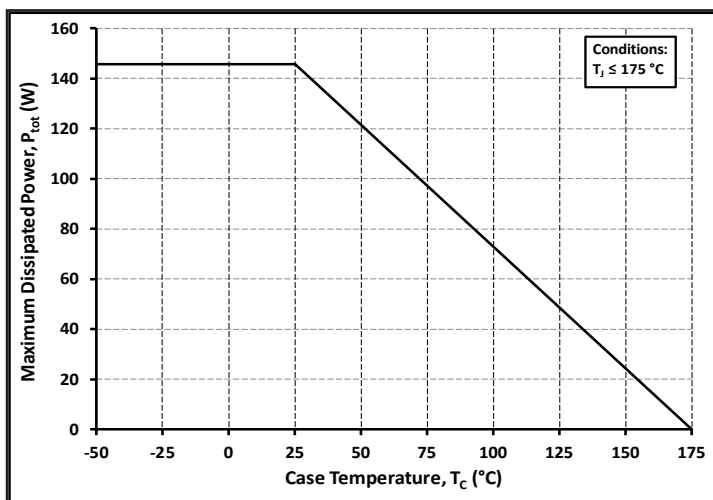


Figure 20. Maximum Power Dissipation Derating vs. Case Temperature

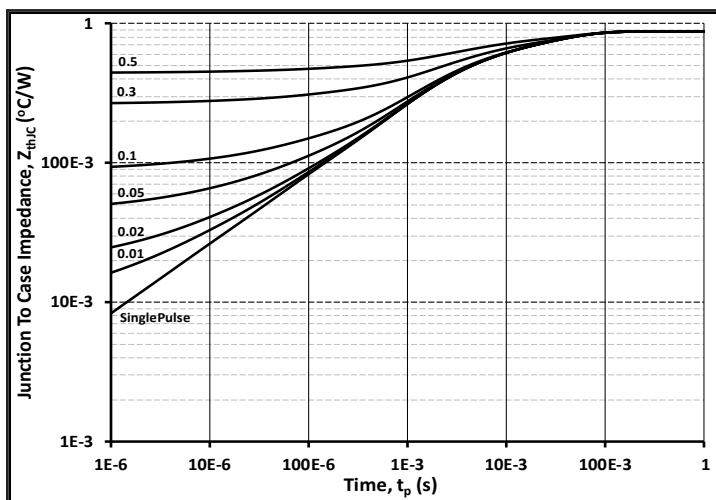


Figure 21. Transient Thermal Impedance (Junction - Case)

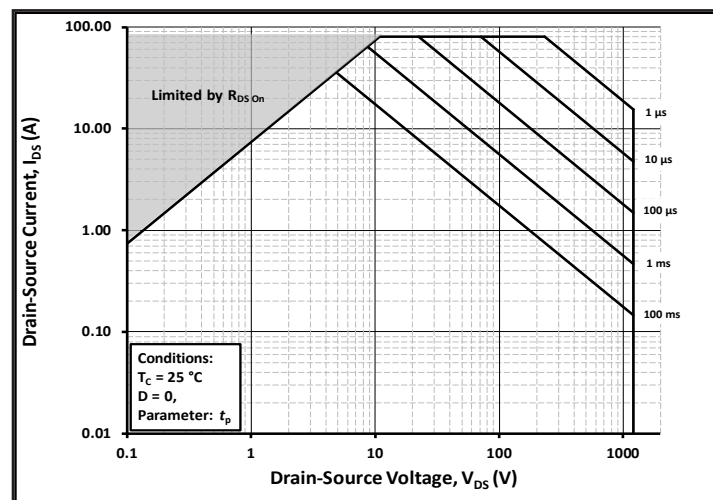


Figure 22. Safe Operating Area

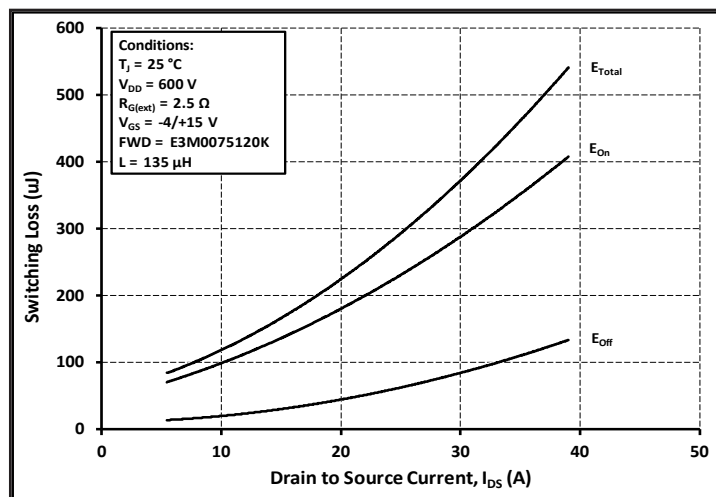


Figure 23. Clamped Inductive Switching Energy vs. Drain Current ($V_{DD} = 600V$)

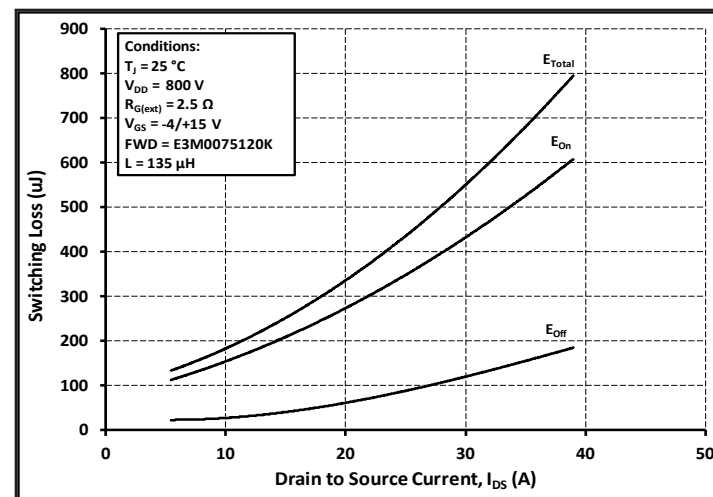


Figure 24. Clamped Inductive Switching Energy vs. Drain Current ($V_{DD} = 800V$)

Typical Performance

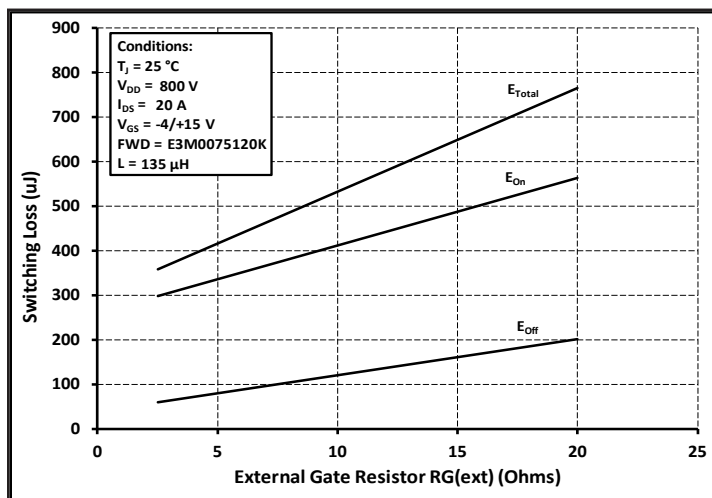


Figure 25. Clamped Inductive Switching Energy vs. $R_{G(ext)}$

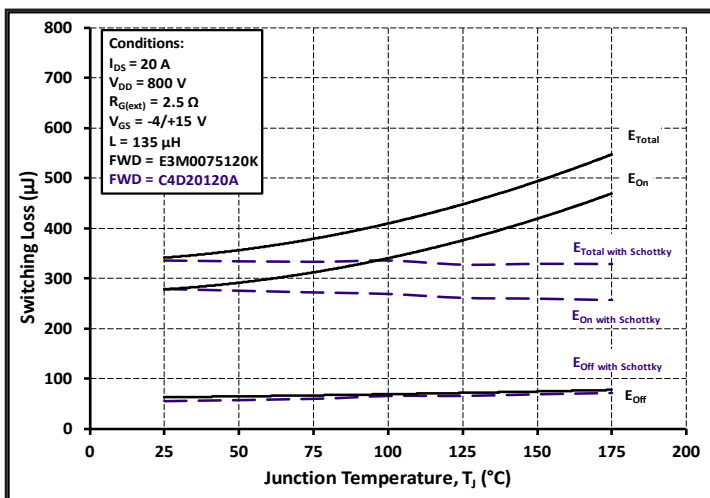


Figure 26. Clamped Inductive Switching Energy vs. Temperature

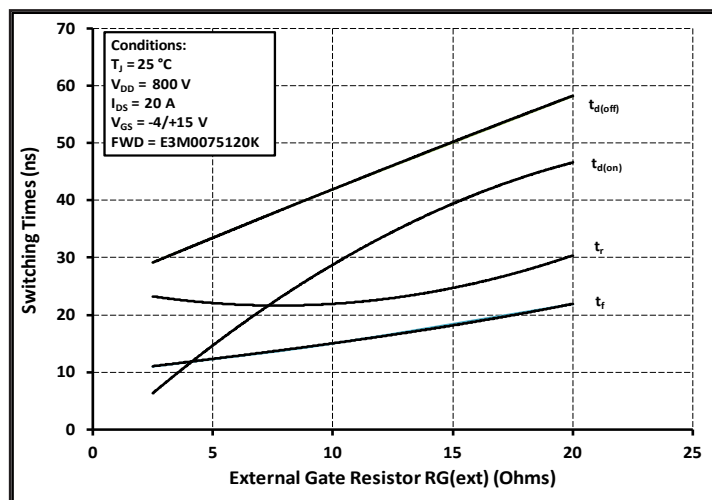


Figure 27. Switching Times vs. $R_{G(ext)}$

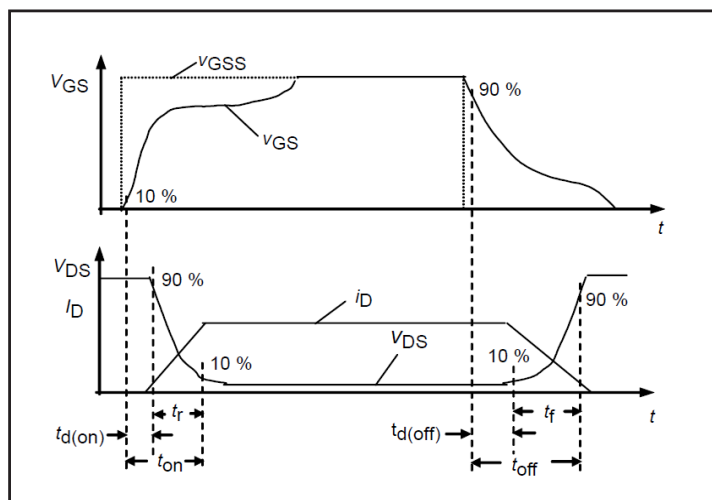


Figure 28. Switching Times Definition

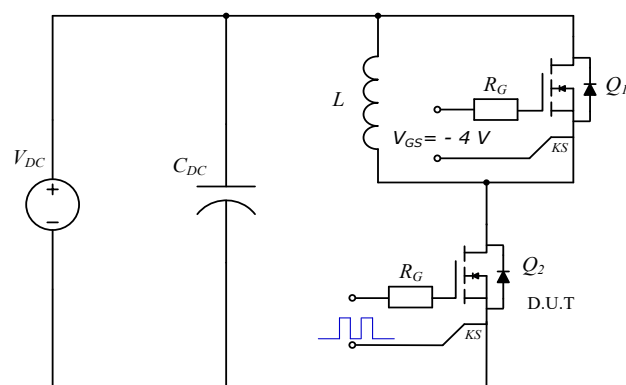
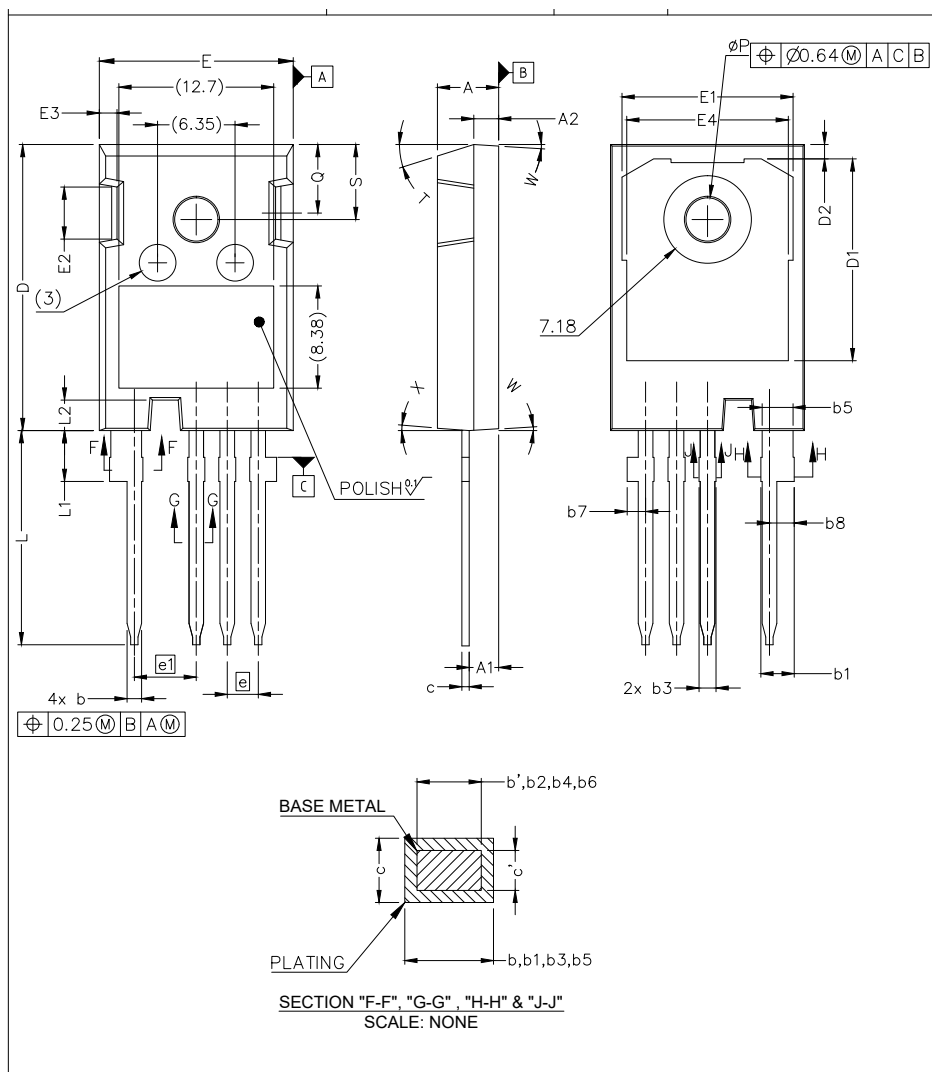


Figure 29. Clamped Inductive Switching
Waveform Test Circuit

Package Dimensions TO-247-4L



Package Dimensions TO-247-4L

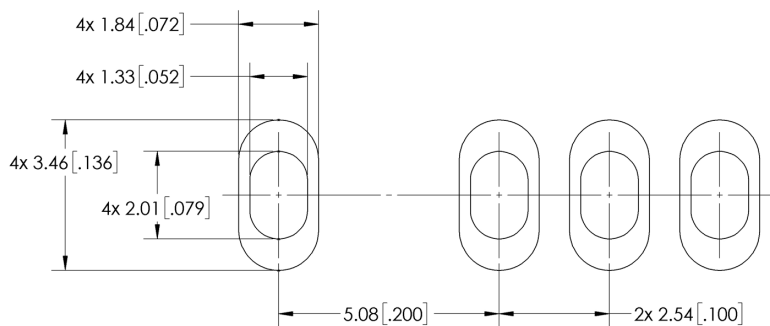
NOTE ;

1. ALL METAL SURFACES: TIN PLATED, EXCEPT AREA OF CUT.
2. DIMENSIONING & TOLERANCEING CONFIRM TO ASME Y14.5M-1994.
3. ALL DIMENSIONS ARE IN MILLIMETERS.
ANGLES ARE IN DEGREES.
4. 'N' IS THE NUMBER OF TERMINAL POSITIONS.
5. DIMENSION DO NOT INCLUDE BURR OR MOLD FLASH.

SYM	MILLIMETERS	
	MIN	MAX
A	4.83	5.21
A1	2.29	2.54
A2	1.91	2.16
b'	1.07	1.28
b	1.07	1.33
b1	2.39	2.94
b2	2.39	2.84
b3	1.07	1.60
b4	1.07	1.50
b5	2.39	2.69
b6	2.39	2.64
b7	1.30	1.70
b8	1.80	2.20

c'	0.55	0.65
c	0.55	0.68
D	23.30	23.60
D1	16.25	17.65
D2	0.95	1.25
E	15.75	16.13
E1	13.10	14.15
E2	3.68	5.10
E3	1.00	1.90
E4	12.38	13.43
e	2.54 BSC	
e1	5.08 BSC	
N*	4	
L	17.31	17.82
L1	3.97	4.37
L2	2.35	2.65
øP	3.51	3.65
Q	5.49	6.00
S	6.04	6.30
T	17.5° REF.	
W	3.5 ° REF.	
X	4° REF.	

Recommended Solder Pad Layout



Revision history

Document Version	Date of release	Description of changes
2.0	March-2021	Final Datasheet

Notes

- **RoHS Compliance**
The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS2), as implemented January 2, 2013. RoHS Declarations for this product can be obtained from your Cree representative or from the Product Documentation sections of www.cree.com.
- **REACH Compliance**
REACH substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact a Cree representative to insure you get the most up-to-date REACH SVHC Declaration. REACH banned substance information (REACH Article 67) is also available upon request.
- This product has not been designed or tested for use in, and is not intended for use in, applications implanted into the human body nor in applications in which failure of the product could lead to death, personal injury or property damage, including but not limited to equipment used in the operation of nuclear facilities, life-support machines, cardiac defibrillators or similar emergency medical equipment, aircraft navigation or communication or control systems, air traffic control systems.

Related Links

- **SPICE Models:** <http://wolfspeed.com/power/tools-and-support>
- **SiC MOSFET Isolated Gate Driver reference design:** <http://wolfspeed.com/power/tools-and-support>
- **SiC MOSFET Evaluation Board:** <http://wolfspeed.com/power/tools-and-support>